

Taiwan Semiconductor

# **N-Channel Power MOSFET**

 $600V, 9.5A, 0.38\Omega$ 

### FEATURES

- Super-Junction technology
- High performance due to small figure-of-merit
- High ruggedness performance
- High commutation performance
- Pb-free plating
- Compliant to RoHS Directive 2011/65/EU and in accordance to WEEE 2002/96/EC
- Halogen-free according to IEC 61249-2-21

### APPLICATIONS

- Power Supply
- Lighting

TO-252 (DPAK)





ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub> = 25°C unless otherwise noted)					
PARAMETER		SYMBOL	IPAK/DPAK	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	600	V	
Gate-Source Voltage		V <sub>GS</sub>	±30	V	
Continuous Drain Current (Note 1)	$T_{\rm C} = 25^{\circ}{\rm C}$		9.5	А	
	$T_{c} = 100^{\circ}C$	ID	6	А	
Pulsed Drain Current (Note 2)		I <sub>DM</sub>	28.5	А	
Total Power Dissipation @ $T_c = 25^{\circ}C$		P <sub>DTOT</sub>	83	W	
Single Pulsed Avalanche Energy (Note 3)		E <sub>AS</sub>	64	mJ	
Single Pulsed Avalanche Current (Note 3)		I <sub>AS</sub>	1.6	А	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	- 55 to +150	°C	

THERMAL PERFORMANCE				
PARAMETER	SYMBOL	IPAK/DPAK	UNIT	
Junction to Case Thermal Resistance	R <sub>eJC</sub>	1.5	°C/W	
Junction to Ambient Thermal Resistance	R <sub>θJA</sub>	62	°C/W	

**Thermal Performance Note:**  $R_{\Theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistances. The case-thermal reference is defined at the solder mounting surface of the drain pins.  $R_{\Theta JA}$  is guaranteed by design while  $R_{\Theta CA}$  is determined by the user's board design.  $R_{\Theta JA}$  shown below for single device operation on FR-4 PCB in still air.

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KEY PERFORMANCE PARAMETERS			
PARAMETER	VALUE	UNIT	
V <sub>DS</sub>	600	V	
R <sub>DS(on)</sub> (max)	0.38	Ω	
Qg	19.4	nC	





## TSM60NB380CP



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PARAMETER	CONDITIONS	SYMBOL	MIN	ТҮР	MAX	UNIT
Static						•
Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	BV <sub>DSS</sub>	600			V
Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	V <sub>GS(TH)</sub>	2	3	4	V
Gate Body Leakage	$V_{GS} = \pm 30V, V_{DS} = 0V$	I <sub>GSS</sub>			±100	nA
Zero Gate Voltage Drain Current	$V_{DS} = 600V, V_{GS} = 0V$	I <sub>DSS</sub>			1	μA
Drain-Source On-State Resistance (Note 4)	$V_{GS} = 10V, I_D = 2.85A$	R <sub>DS(on)</sub>		0.26	0.38	Ω
Dynamic (Note 5)					1	L
Total Gate Charge	$V_{DS} = 380V, I_D = 9.5A,$ $V_{GS} = 10V$	Qg		19.4		
Gate-Source Charge		Q <sub>gs</sub>		3.5		nC
Gate-Drain Charge		Q <sub>gd</sub>		8.9		1
Input Capacitance	$V_{DS} = 100V, V_{GS} = 0V,$	C <sub>iss</sub>		795		_
Output Capacitance	f = 1.0MHz	C <sub>oss</sub>		67		pF
Gate Resistance	F = 1MHz, open drain	R <sub>g</sub>		3.1		Ω
Switching (Note 6)						
Turn-On Delay Time	$V_{DD} = 380V,$ $R_{GEN} = 25\Omega,$ $I_D = 9.5A, V_{GS} = 10V,$	t <sub>d(on)</sub>		23.6		
Turn-On Rise Time		t <sub>r</sub>		11.6		
Turn-Off Delay Time		t <sub>d(off)</sub>		66		ns
Turn-Off Fall Time	$10 - 9.3$ , $v_{GS} - 10$ v,	t <sub>f</sub>		9.6		1
Source-Drain Diode						
Forward Voltage (Note 4)	I <sub>S</sub> = 9.5A, V <sub>GS</sub> = 0V	V <sub>SD</sub>			1.4	V
Reverse Recovery Time	V <sub>R</sub> = 100V, I <sub>S</sub> = 9.5A	t <sub>rr</sub>		272		ns
Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	Q <sub>rr</sub>		2.9		μC

Notes:

1. Current limited by package.

2. Pulse width limited by the maximum junction temperature.

3. L = 50mH, I\_{AS} = 1.6A, V\_{DD} = 50V, R\_G = 25\Omega, Starting T\_J =  $25^{\circ}C$ 

4. Pulse test:  $PW \le 300\mu s$ , duty cycle  $\le 2\%$ .

5. For DESIGN AID ONLY, not subject to production testing.

6. Switching time is essentially independent of operating temperature.

#### **ORDERING INFORMATION**

PART NO.	PACKAGE	PACKING	
TSM60NB380CP ROG	TO-252 (DPAK)	2,500pcs / 13" Reel	



#### **CHARACTERISTICS CURVES**

 $(T_c = 25^{\circ}C \text{ unless otherwise noted})$ 



#### **On-Resistance vs. Drain Current** $R_{DS(on)}$ , Drain-Source On-Resistance ( $\Omega$ ) 0.55 0.50 0.45 0.40 V<sub>GS</sub> = 10V 0.35 V<sub>GS</sub> = 20V 0.30 0.25 \*Note: T<sub>c</sub> = 25°C 0.20 5 15 0 10 20 25 30 I<sub>D</sub>, Drain Current (A)

**On-Resistance vs. Junction Temperature** 



 $(V_{DS}=10V)$ 

#### Transfer Characteristics

Gate-Source Voltage vs. Gate Charge



Source-Drain Diode Forward Current vs. Voltage





#### **CHARACTERISTICS CURVES**

 $(T_c = 25^{\circ}C \text{ unless otherwise noted})$ 



Maximum Safe Operating Area



V<sub>DS</sub>, Drain to Source Voltage (V)



Normalized Thermal Transient Impedance, Junction-to-Case

BV<sub>DSS</sub> (Normalized) Drain-Source Breakdown Voltage





#### PACKAGE OUTLINE DIMENSIONS (Unit: Millimeters)



#### SUGGESTED PAD LAYOUT (Unit: Millimeters)



#### **MARKING DIAGRAM**





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